

SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic SOT143 microminiature envelope with source and substrate interconnected and intended for VHF applications in television tuners.

The device is also suitable for use in professional communication equipment.

This MOS-FET tetrode is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

QUICK REFERENCE DATA

Drain-source voltage	V_{DS}	max.	20 V
Drain current	I_D	max.	30 mA
Total power dissipation up to $T_{amb} = 60^\circ\text{C}$	P_{tot}	max.	200 mW
Junction temperature	T_j	max.	150 °C
Transfer admittance at $f = 1 \text{ kHz}$ $I_D = 10 \text{ mA}; V_{DS} = 15 \text{ V}; + V_{G2-S} = 4 \text{ V}$	$ y_{fs} $	typ.	18 mS
Input capacitance at gate 1; $f = 1 \text{ MHz}$ $I_D = 10 \text{ mA}; V_{DS} = 15 \text{ V}; + V_{G2-S} = 4 \text{ V}$	C_{ig1-s}	typ. max.	2.5 pF 3.0 pF
Feedback capacitance at $f = 1 \text{ MHz}$ $I_D = 10 \text{ mA}; V_{DS} = 15 \text{ V}; + V_{G2-S} = 4 \text{ V}$	C_{rs}	typ.	25 fF
Noise figure at $G_S = 2 \text{ mS}; B_S = B_{S \text{ opt}}$ $I_D = 10 \text{ mA}; V_{DS} = 15 \text{ V}; + V_{G2-S} = 4 \text{ V}; f = 200 \text{ MHz}$	F	typ.	1.0 dB

MECHANICAL DATA

Fig.1 SOT143.

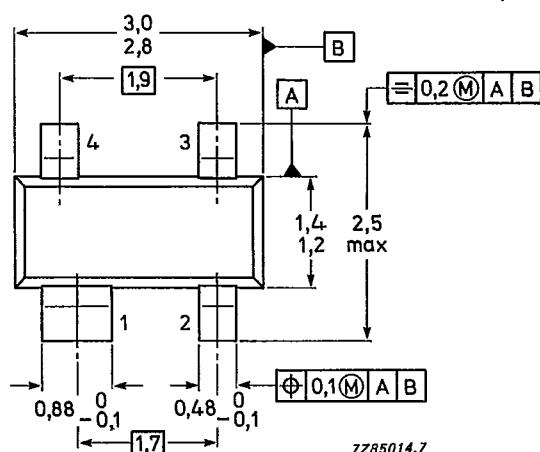
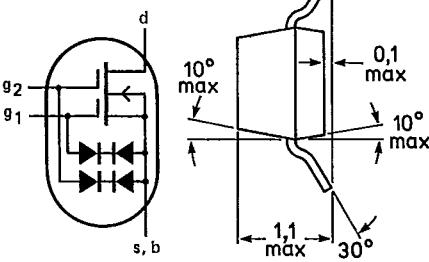
Pinning

1 = source

2 = drain

3 = gate 2

4 = gate 1



TOP VIEW

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	V_{DS}	max.	20 V
Drain current (DC or average)	I_D	max.	30 mA
Gate 1-source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2-source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 60^\circ\text{C}$ (note 1)	P_{tot}	max.	200 mW
Storage temperature	T_{stg}		-65 to + 150 °C
Junction temperature	T_j	max.	150 °C

THERMAL RESISTANCE

From junction to ambient in free air (note 1) $R_{th\ j-a}$ = 460 K/W

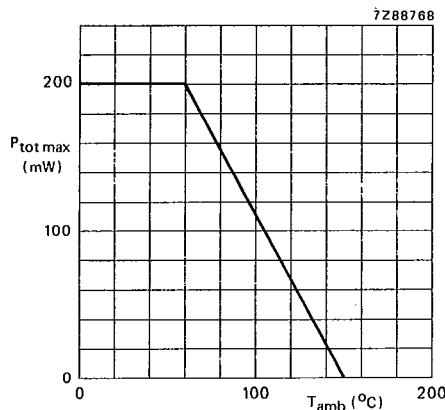


Fig. 2 Power derating curve.

Note

1. Device mounted on a ceramic substrate of 8 mm x 10 mm x 0.7 mm.

STATIC CHARACTERISTICS $T_j = 25^\circ\text{C}$ unless otherwise specified

Gate cut-off currents

$\pm V_{G1-S} = 5 \text{ V}; V_{G2-S} = V_{DS} = 0$	$\pm I_{G1-SS}$	max.	50 nA
$\pm V_{G2-S} = 5 \text{ V}; V_{G1-S} = V_{DS} = 0$	$\pm I_{G2-SS}$	max.	50 nA

Gate-source breakdown voltages

$\pm I_{G1-S} = 10 \text{ mA}; V_{G2-S} = V_{DS} = 0$	$\pm V_{(BR)G1-SS}$	6 to 20	V
$\pm I_{G2-S} = 10 \text{ mA}; V_{G1-S} = V_{DS} = 0$	$\pm V_{(BR)G2-SS}$	6 to 20	V

Drain current

$V_{DS} = 15 \text{ V}; V_{G1-S} = 0; V_{G2-S} = 4 \text{ V}$	I_{DSS}	4 to 20	mA
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Gate-source cut-off voltages

$I_D = 20 \mu\text{A}; V_{DS} = 15 \text{ V}; +V_{G2-S} = 4 \text{ V}$	$-V(P)G1-S$	max.	2.5 V
$I_D = 20 \mu\text{A}; V_{DS} = 15 \text{ V}; V_{G1-S} = 0$	$-V(P)G2-S$	max.	2.0 V

DYNAMIC CHARACTERISTICSMeasuring conditions (common source): $I_D = 10 \text{ mA}; V_{DS} = 15 \text{ V}; +V_{G2-S} = 4 \text{ V}; T_{amb} = 25^\circ\text{C}$.

Transfer admittance at $f = 1 \text{ kHz}$	y_{fsl}	min.	15 mS
		typ.	18 mS
Input capacitance at gate 1: $f = 1 \text{ MHz}$	C_{ig1-s}	typ.	2.5 pF
		max.	3.0 pF
Input capacitance at gate 2: $f = 1 \text{ MHz}$	C_{ig2-s}	typ.	1.2 pF
Feedback capacitance at $f = 1 \text{ MHz}$	C_{rs}	typ.	25 fF
Output capacitance at $f = 1 \text{ MHz}$	C_{os}	typ.	1.0 pF
Noise figure at $G_S = 2 \text{ mS}; B_S = B_S \text{ opt}; f = 200 \text{ MHz}$	F	typ.	1.0 dB
Power gain at $G_S = 2 \text{ mS}; B_S = B_S \text{ opt}$ $G_L = 0.5 \text{ mS}; B_L = B_L \text{ opt}; f = 200 \text{ MHz}$	G_p	typ.	25 dB